

## S17 + Maintenance Guide

Date of Version: 2019-11-25

File category: Maintenance plan

**Contents of this manual:** referring to how to troubleshoot the S17+ hashboard and how to use hashboard tester to accurately locate it.

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### I. Maintenance Platform / Tool Preparation

1. Platform requirements: rubber sheet maintenance workbench (workbench needs to be grounded), anti-static wrist strap and grounding.

2. Constant temperature soldering iron (350–360°C), the head of tip soldering iron is used to solder small patches such as chip resistors and capacitors, etc.; heat gun, BGA rework station for chip / BGA disassembly and soldering; multimeter, soldering steel pin and shrink tubing for easy measurement (Fluke recommended); oscilloscope (Agilent recommended)

3. Testing tool requirements: APW9 + power supply and power patch cord for power supply of hashboard; 2.1040 control board, hashboard tester.

4. Requirements for maintenance auxiliary materials / tool: low-temperature solder paste Alpha OM550, flux, water for cleaning panel and anhydrous alcohol; water for cleaning panel is used to clean up soldering residues after repair; thermal conductive paste is used to apply on chips / heat sinks after maintenance (some models require thermal conductive paste); tin-planting steel mesh, ball-planting steel mesh, solder wire, solder ball (ball diameter is recommended to be 0.4mm); when replacing a new chip, you need to plant tin on chip pin and the BSM surface before soldering them to the hashboard.

5. Demand for common maintenance spare materials: 0402 resistance (0R, 33R, 1K, 4.7K,); 0201 resistance (0R), 0402 capacitor (0.1uf, 1uf)



## **II. Operation Requirements**

1. Maintenance personnel must have certain electronic knowledge, more than one year of maintenance experience, and be proficient in BGA / QFN / LGA package soldering technology.

2. After repairing, the hashboard must be tested to be OK for more than twice, otherwise, it shall be rejected.

3. Please pay attention to the operation method when replacing the chip. There should be no obvious deformation of the PCB board after replacing any accessories. Check whether there are any open or short circuits, or missing parts in the replacement parts and the surroundings.

4. Check the tools, confirm whether the test fixtures can work normally, determine the test software parameters for the maintenance station, and version of test fixtures, etc.

5. After passing the repair and replacement chip test, you need to check the full chip before performing the functional test. The functional test shall ensure that the double-sided heat sinks are soldered OK and the cooling fan is at full speed. When using the chassis cooling function, you must put 3 hashboards at the same time to form air duct. The single-sided test of production must also ensure the formation of air ducts (important).

6. When measuring the signal, two fans are used to dissipate heat as assistance measure, and the fans maintain full speed.

7. For the front and back of the hashboard, the steel windshield is under 21V voltage. During the measurement and maintenance, please keep the maintenance table clean and insulated to avoid short circuit during the maintenance.



8. When replacing a new chip, apply solder paste on the pins and the BSM surface to ensure that the chip is pre-tinned before soldering to PCBA for maintenance.

9. Fixtures at the maintenance end adopt Repair\_Mode mode and config configuration files tested in non-scanning mode. After passing the test, the production end starts the production line from test piece; the after-sale end is normally installed and aged (installed at the same level). The test configuration file can be obtained from TE.

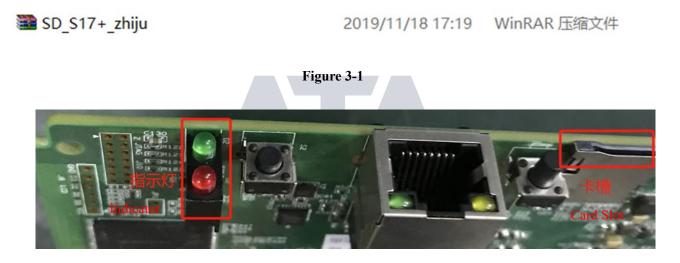


## **III. Production of Hashboard Tester and Precautions**

The supporting clamps of hashboard tester should meet the requirements for heat dissipation of the hashboard and facilitate the measurement of signals.

1. Calibrate the hashboard tester.

2. Use the test fixture SD card flash program to update the control board FPGA. After decompression, copy to the SD card and insert the card into the fixture card slot. Power on for about 1 minute and wait for the control board indicator to flash for 3 times, then complete the update.



#### Figure 3-2

3. The test SD card will be produced according to the requirements. The single-sided heat sink uses the file before brushing to make the SD card; the double-sided heat sink uses the file after brushing to make the SD card.

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#### Figure 3-3

4. The double-sided test at the production end requires a code scanning gun and serial port tools. Please refer to the test process file for details.

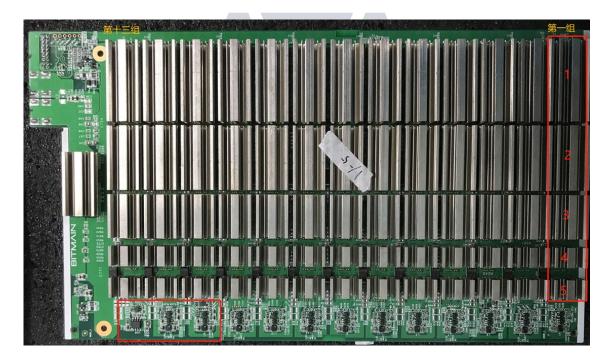


5. The after-sale end and outsourced maintenance side does not need to use the code scanning method (hashboard tester SD card configuration file needs to be changed, the demand can be submitted to TE and TE will test the config configuration file for hashboard tester).

## **IV. Principle Overview**

1. S17+ hashboard working structure:

The hashboard is composed of 65 BM1397 chips, which are divided into 13 groups, each group is composed of 5 ICs; the working voltage of the BM1397 chip used by the S17 hashboard is 1.5V; the last 24.5V output by the boost circuit U6 powers the LDO, LDO outputs 1.8V, the last third and third groups are powered by 24.5V DCDC to output 1.8V, and the other groups are powered by 21V divided voltage to provide 1.8V through DCDC. All 0.8V is provided by the 1.8V of this domain via the LDO output, as shown in Figure 4-1.





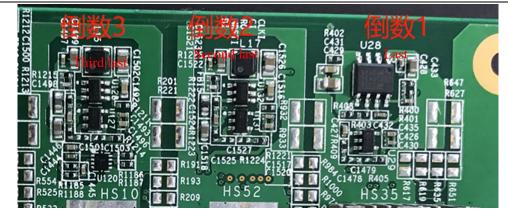
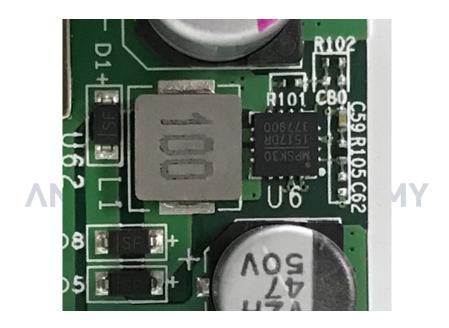


Figure 4-1

#### 2. S17 hashboard boost circuit:

The boost is from 21V to 24.5V powered by the power supply, as shown in Figure 4-2.





#### 3. S17 chip signal direction:

3.1 CLK (XIN) signal direction: It is generated by Y1 25M crystal oscillator and transmitted from chip 01 to chip 65. During operation, the voltage is 1.45-1.65V(oscilloscope). Voltage measured by multimeter is about 0.7-0.9V.

3.2. TX (CI, CO) signal direction: input from pin 7 (3.3V) of IO port, transferred to IC U2 through level conversion, then transmitted from chip 01 to chip 65; the voltage is 0V when the IO line is not inserted, and the voltage during operation is 1.8V.

3.3 RX (RI, RO) signal direction: from chip 65 to chip 01, return to pin 8 of the signal cable terminal via U1 and



return to the control board; the voltage is 0.3V when the IO line is not inserted, and the voltage during operation is 1.8V.

3.4 BO (BI, BO) signal direction: from chip 01 to chip 65; voltage measured using multimeter is 0V.

3.5 RST signal direction: input from pin 3 of the IO port, and then transmitted from chip 01 to chip 65; 0V without IO signal or in standby and 1.8V in operation.

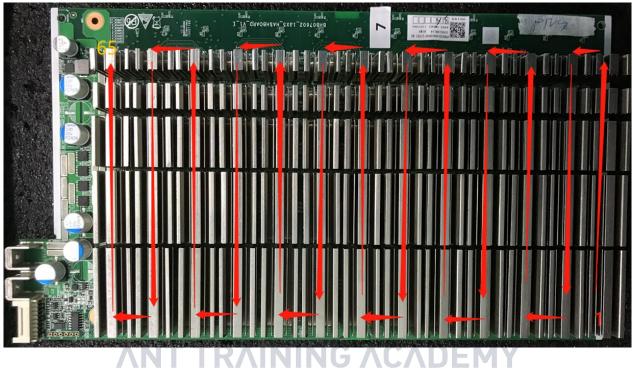
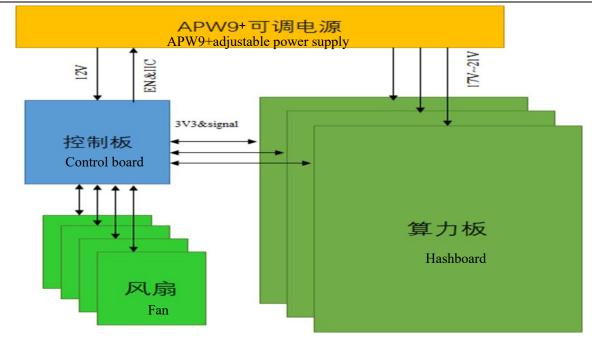


Figure 4-3

4, Overall architecture:

1. The machine is mainly composed of 3 hashboards, 1 control board, APW9 + power supply, and 4 cooling fans, as shown in Figure 4-4.



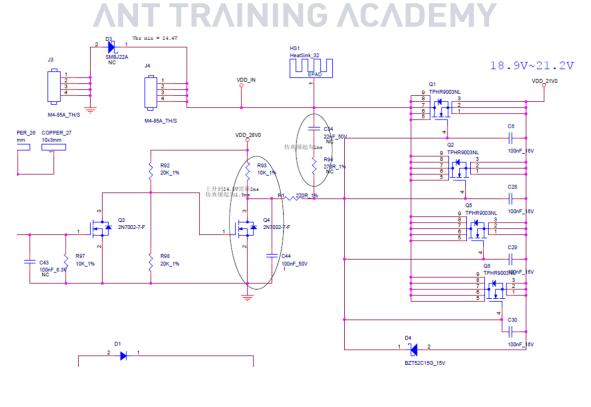




## V. Common Poor Phenomenon of Hashboard and Troubleshooting Procedure

Phenomenon: during single board test, chip is detected to be 0 (PT1 / PT2 station type)

Step one: check the power output first. Please check the circled part in Figure 5-1.





#### Figure 5-1

Step two: check the voltage domain voltage output

The voltage in each voltage domain is about 1.6V. Generally, there is a domain voltage when power is supplied at 21V. It is preferred to measure the output of the power supply terminal of the hashboard and determine whether the MOS is shorted (measure the resistance between pins 1, 4, and 8). If there is power supply at 21V but no domain voltage, continue to check downward.

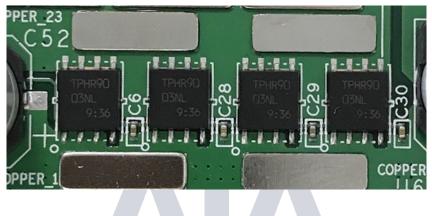
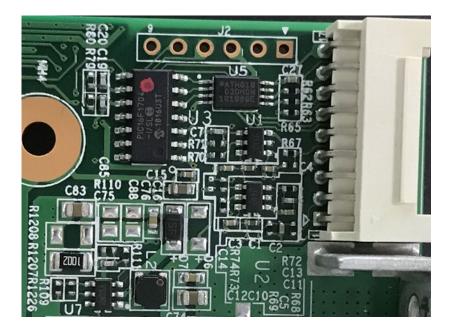


Figure 5-2

Step three: check the PIC circuit

Measure whether the second pin of U3 has an output, the voltage is about 3.2V; if yes, please continue to troubleshoot, if there is no 3.3V, please check that the connection status of the fixture cable and the hashboard is OK, and re-program the PIC.







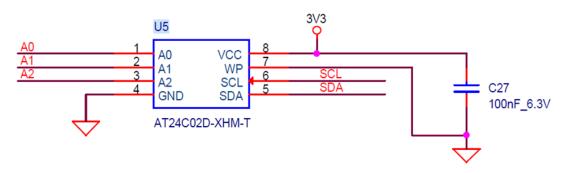
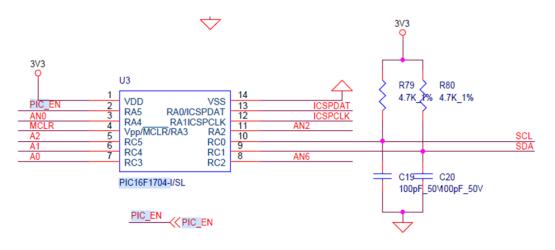


Figure 5-4



## **ΛΝΤ TRΛIN<sup>Figure 5-5</sup> ΛCΛDEMY**

PIC programming procedure:

1. Program the PIC program of the arithmetic board.

Procedure: 20190908-PIC1704-BHB07602-0x88.hex

Download the programming tool: PICkit3; pin 1 of the PICkit3 cable corresponds to pin 1 of J3 on the PCB, and pins 1, 2, 3, 4, 5, and 6 need to be connected.

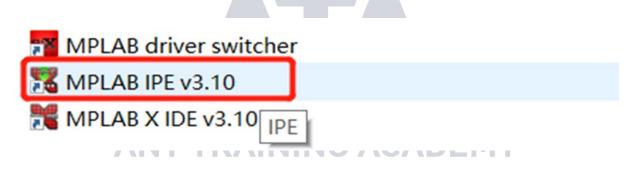






2. Programming software:

Open MPLAB IPE, select device: PIC16F1704, click power to select the power supply method, and then click operate. First step: select the file to find the .HEX file to be programmed. Second step: click connect to connect normally. Third step: click the program button, then click verify after finish. Prompt will be sent to prove that the programming is successful.





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File View Settings Hel	p	File View Settings He	lp	
1 ⊕Operate	Select Device and Tool Results Family: All Families  CP=OFF Checksum: [ECO7 Checksum: [ECO7	• Operate	Voltage Settings	
• Power	Device: PICIGFITO4	😝 Power	VDD: 5.0 ~	
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• Environment	Source: [凡老化测试给工厂20191030\单板及整机老化测试给工厂20191030\PIC\BHB07702.hex] Brow SQTP: [Please click on browse button to import SQTP file 图 图 Brow	• Environment	VDD App: 5.0 ~	
• SQTP	[Output]           2019-11-06T15:03:52*0800- Completed loading IPE.	• SQTP		Reset Volt
• Production	2019-11-06115:05:35+0800- Loading hex file. Please wait 正在加載代码::没科文件VENB07T02(T1?+)\单板及整机老化测试给工厂20191030\单板及整机老化测试给 工厂2019:10301F1CEBB07T02.hex 2019-11-06115:05:35+0500-Bex file loaded successfully.	• Production	ICSP Options	
Settings		Settings	Power Target Circuit from Tool	High Voltage on MCLR
• Log out		• Log out	Status	

Figure 5-8



#### Step four: check the boost circuit output

Test D5 / D8 in chart 5-9 to measure 23-24.5V voltage.

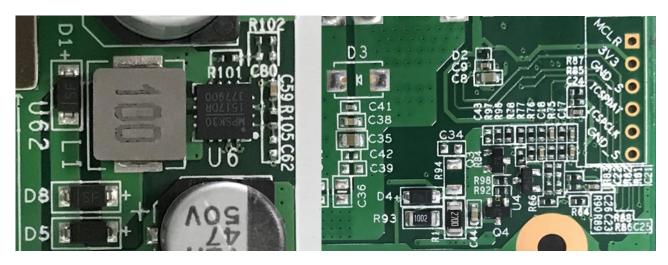
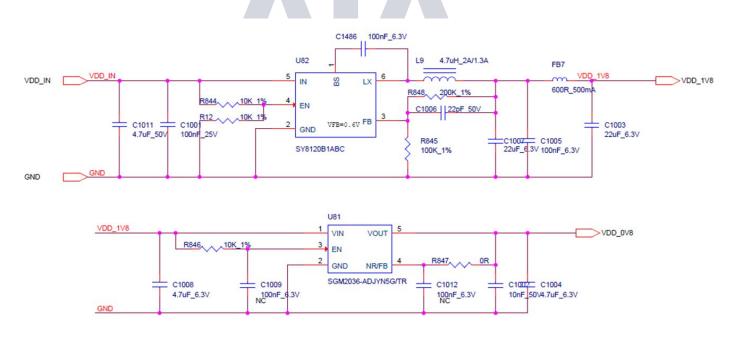


Figure 5-9

Step five: check the LDO 1.8V or PLL 0.8V output of each group

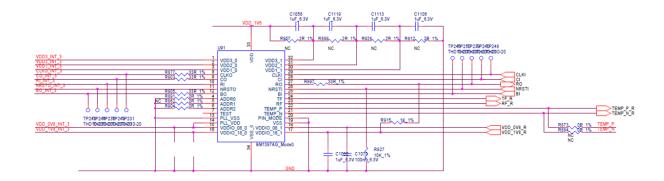




Step six: check the chip signal output (CLK / CI / RI / BO / RST)

Refer to the range of voltage values described by the signal direction. If the measurement encounters a large deviation in voltage value, it can be compared with the measured values of adjacent groups.







Assuming that the chip signal pin output voltage is normal, if the chip is still incomplete, for example, if 64 chips are detected, you can troubleshoot by shorting RO pull-up resistor R639. If 64 chips can be detected after shorting, it indicate that chips 1-64 should be normal, and you can troubleshoot the 65th chip at this time. If 63 chips are detected after short-circuiting, conduct troubleshooting forward; it is recommended to adopt the dichotomy method for troubleshooting, that is, test from the middle (starting from the 32<sup>th</sup>).

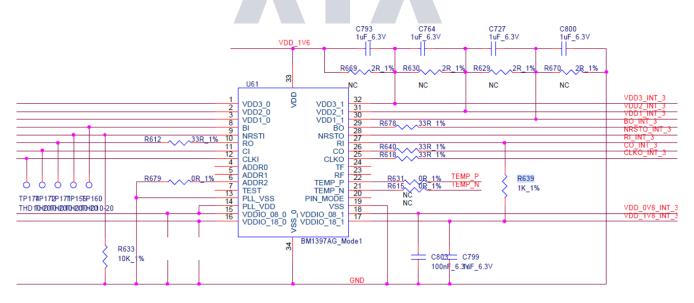


Figure 5-12

Troubleshooting comparison table:



#### Table 1

Resistor shorted	Chip code checked	Phenomenon description	Resistor shorted	Chip code checked	Phenomenon
R322	U21	Detect 1 ASIC	R376	U27	description Detect 33 ASICs
R302	U20	Detect 2 ASICs	R370 R357	U23	Detect 34 ASICs
R302 R304	U22	Detect 3 ASICs	R1139	U24	Detect 35 ASICs
R304 R285	U18	Detect 4 ASICs	R1083	U108	Detect 35 ASICs
R283 R1067	U18 U19	Detect 5 ASICs	R1137	U108	Detect 37 ASICs
				U103 U106	-
R1011	U103	Detect 6 ASICs	R1126		Detect 38 ASICs
R1065	U100	Detect 7 ASICs	R1133	U107	Detect 39 ASICs
R1054	U101	Detect 8 ASICs	R826	U104	Detect 40 ASICs
R1061	U102	Detect 9 ASICs	R822	U75	Detect 41 ASICs
R754	U99	Detect 10 ASICs	R802	U74	Detect 42 ASICs
R750	U70	Detect 11 ASICs	R804	U76	Detect 43 ASICs
R730	U69	Detect 12 ASICs	R785	U72	Detect 44 ASICs
R732	U71	Detect 13 ASICs	R541	U73	Detect 45 ASICs
R713	U67	Detect 14 ASICs	R485	U40	Detect 46 ASICs
R469	U68	Detect 15 ASICs	R539	U37	Detect 47 ASICs
R413	U35	Detect 16 ASICs	R528	U38	Detect 48 ASICs
R467	U32	Detect 17 ASICs	R535	U39	Detect 49 ASICs
R456	U33	Detect 18 ASICs	R254	U36	Detect 50 ASICs
R463	U34	Detect 19 ASICs	R250	U16	Detect 51 ASICs
R182	U31	Detect 20 ASICs	R230	U15	Detect 52 ASICs
R178	U11	Detect 21 ASICs	R232	<b>D U</b> 17	Detect 53 ASICs
R158	U10	Detect 22 ASICs	R213	U13	Detect 54 ASICs
R160	U12	Detect 23 ASICs	R987	U14	Detect 55 ASICs
R141	U8	Detect 24 ASICs	R931	U96	Detect 56 ASICs
R915	U9	Detect 25 ASICs	R985	U93	Detect 57 ASICs
R859	U91	Detect 26 ASICs	R974	U94	Detect 58 ASICs
R913	U88	Detect 27 ASICs	R981	U95	Detect 59 ASICs
R902	U89	Detect 28 ASICs	R680	U92	Detect 60 ASICs
R909	U90	Detect 29 ASICs	R676	U64	Detect 61 ASICs
R398	U87	Detect 30 ASICs	R656	U63	Detect 62 ASICs
R394	U26	Detect 31 ASICs	R658	U65	Detect 63 ASICs
R374	U25	Detect 32 ASICs	R639	U61	Detect 64 ASICs
		n shin is incomplet			

2. Phenomenon: Single board detection chip is incomplete (PT1 / PT2 station)

Check the relevant signals (CLK / CI / RI / BO / RST) of the chip in front of and behind the error position, locate the bad position according to the IC with the abnormal signal measured, and refer to the signal direction and voltage range for repair.



3. Phenomenon: single board pattern NG, that is, the response nonce data is incomplete (PT2 station type)

The serial port is connected to the computer, and the computer reads the test log; according to the results displayed in the log, the chip position of insufficient nonce data can be determined; replace the chip at the corresponding position.

4. Phenomenon: Test temperature reading is abnormal (PT2 station)

Check the temperature-sensing power supply VDD and the connection status between the temperature-sensing and the chip (TEMP\_P; TEMP\_N), and check the soldering quality of the chip connected to the corresponding temperature-sensing.

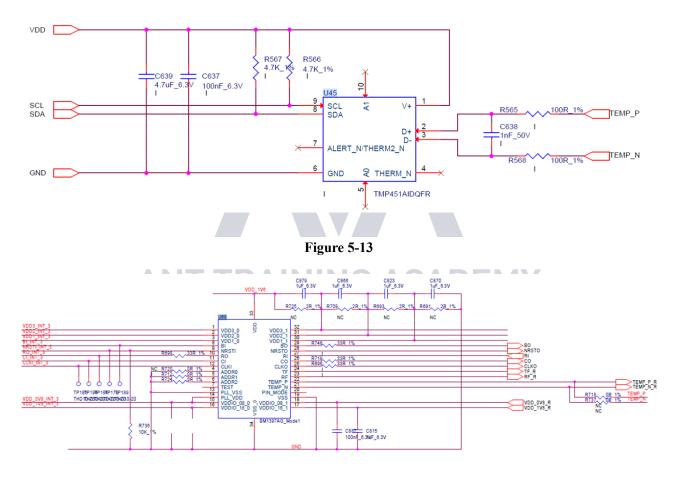


Figure 5-14

Check the quality of the front and back chip heat sinks connected to the temperature sensor. If the heat sink is not welded well, it will affect the temperature difference.



## VI. Problems Caused by Control Board Issues

1. The whole machine is not running

First step: check whether the voltages at several voltage output points are normal. You can disconnect U8 first if 3.3V short circuit. If the short circuit still exists, you can unplug the CPU for measurement. For other voltage abnormalities, replace the corresponding transformer IC in general.

Second step: if the voltage is normal, please check the welding status of DDR / CPU (X-RAY inspection on the production side).

Third step: try to update the flash program with the SD card.

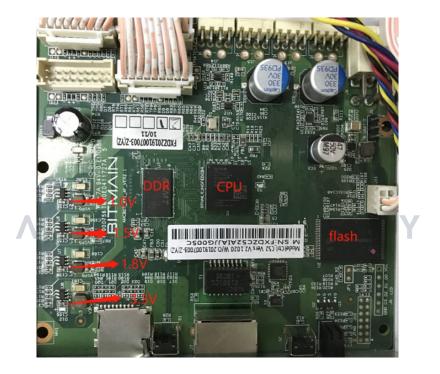


Figure 5-15

2. The whole machine cannot find the IP

Probably the IP is not found due to abnormal operation. Refer to point 1 for troubleshooting.

Check the appearance and soldering of the network port, network transformer T1, and CPU.

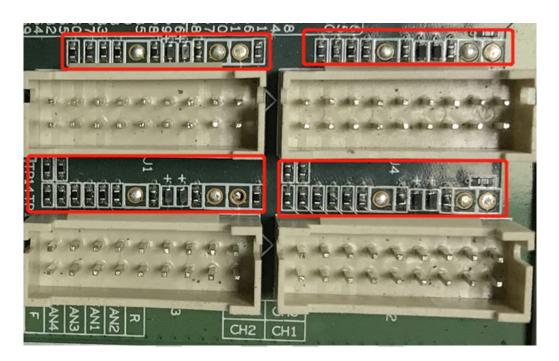
3. The whole machine cannot be upgraded

Check the appearance and soldering of the network port, network transformer T1, and CPU.



4. The whole machine fails to read the hashboard or has fewer chains

- A. Check the cable connection
- B. Check the parts of corresponding chain on the control board
- C. Check the wave soldering quality of the pins and the resistance around the plug-in interface



# **ANT TRAINING ACADEMY**

## VII. Whole Miner Problems

1. Initial test of the whole machine

With reference to the test process documents, the general problems are assembly process issues and control board process issues.

Common phenomena: IP is not detected, the number of fans is abnormal, and the chain is abnormal.

2. The whole machine sweeping frequency band

Low hashrate caused by aging: Check the hashrate deviation of the corresponding hashboard to see if there is a

large difference in hashrate, and take out the hashboard with a large hashrate deviation for test maintenance.

Check whether there's low average hashrate caused by the network interruption.

Large temperature difference caused by hashrate: check the aging environment; for the hashboard with high



temperature, check the welding quality of the heat sink of the hashboard.

Aging machine protection: generally over-temperature protection is required, please control the aging

environment temperature to be less than 40 degrees Celsius.

iner state	5															
Summary						-										
Ver	sion		Elapsed		GH/S(5s)	10	GH/S(avg)	,	oundBlocks		LocalWork	Utili	ly s	UV	Best	tShare
35.	35.0.1.3 3d 14h 11m 23s			0.00	46417.95		0			173078	9.89 64		54.85	4656	4656314978	
Pools																
Pool	URL	User	Status	Diff	GetWorks	Priority	Accepted	Diff1#	DiffA#	DiffR#	DiffS#	Rejected	Discarded	Stale	LSDiff	LSTime
0	No URL	No User	Unknown	0	0	0	0	0	0	0	0	0	0	0	0	0
1	No URL	No User	Unknown	0	0	0	0	0	0	0	0	0	0	0	0	0
2	No URL	No User	Unknown	0	0	0	0	0	0	0	0	0	0	0	0	0
total					0		0	0		0	0	0	0	0		
HW	1908								0.0001%							
AntMiner																
Chain#	ASIC	Fr	requency	Temp(PCB	) Temp	(Chip)				AS	IC status					SIC X time
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3	65		600	74		92						00000 00000 00000 00				Ö
					A COMPANY	1.222										
	Fan# F		Fan1		Fan2	Fa	s3	Fan4		FanS		Fan6	Fan	7	F	an8
Spee	d (r/min)		5880		6000	58	10	5760		0		0	0		0	

#### Figure 7-1

Less chain:

If one of the chains cannot be detected, disassemble the machine and test the corresponding hashboard; if it is determined that the hashboard is faulty, repair the hashboard; if it's determined that the control board is faulty, repair the control board.

ner Statu	s															
Summary																
Ver	sion		Elapsed		GH/S(5s)		GH/S(avg)	Four	dBlocks		LocalWork	Utility	wu		BestSi	hare
35.0.1.3 7d 19h 51m 28s			44419.97		45397.6		0		377660	9.68	634808.29		104771375736			
Pools																
Pool	URL	User	Status	Diff	GetWorks	Priority	Accepted	Diff1#	DiffA#	DiffR#	DiffS#	Rejected	Discarded	State	LSDiff	LSTime
0	No URL	No User	Unknown	0	0	0	0	0	0	0	0	0	0	0	0	0
1	No URL	No User	Unknown	0	0	0	0	0	0	0	0	0	0	0	0	0
2	No URL	No User	Unknown	0	0	0	0	0	0	0	0	0	0	0	0	0
total					0		0	0		0	0	0	0	0		
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AntMiner																
Chain#	ASIC	Fre	nquency	Temp(PCB)	Te	mp(Chip)				AS	IC status				,	ASIC X time
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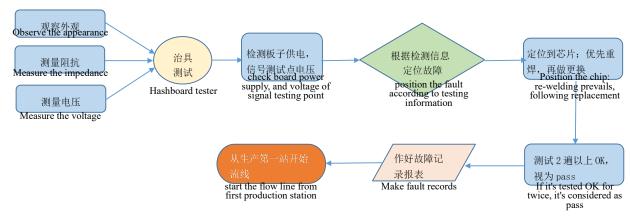


#### 4. After-sales maintenance

Refer to the above troubleshooting steps for each station. For related test procedures and hashboard testers, please communicate with the after-sales engineer for details. After repair, please use non-scanning mode to test PT2.



Maintenance flowchart



## **VIII. Other Matters Needing Attention**

Figure 8-1 Maintenance flowchart

• Routine test: first perform visual inspection on the hashboard to be repaired, observe whether the PCB is deformed or burnt. If yes, it must be handled first; check whether there are any parts with obvious burn marks, collision offset or missing parts, etc.; secondly, if no problem is found through visual inspection, the impedance of each voltage domain can be tested first to detect whether there is a short circuit or an open circuit. If yes, it must be handled first. Third, check whether the voltage of each domain is about 1.5V.

• After the routine test is OK (in general, the short-circuit test is necessary for the routine test to prevent the chip or other materials from being burned due to short circuit when the power is on), you can use the hashboard tester to perform chip detection, and determine the positioning based on the hashboard tester test results.

• According to the display result of the test fixture test, test the voltages of chip test points (CO / NRST / RO / XIN / BI), VDD0V8 and VDD1V8, etc. starting from the vicinity of the faulty chip.

• According to the signal direction (the RX signal is passed in the reverse direction (from chip 65 to 1), and several signals CLK CO BO RST are transmitted in the forward direction (from chip 1 to 65), find the abnormal fault point through the power supply sequence.

• When locating to the faulty chip, the chip needs to be re-soldered. The method is to add a flux around the chip (preferably no-clean flux), and heat the solder joints of the chip pins to a dissolved status, so as to promote the chip pins and the pads to re-run, then removing tin finally, thus achieving the effect of re-tinning. If the failure is



the same after re-soldering, the chip shall be replaced directly.

• The repaired hashboard can be determined to be a good product if it passes the fixture tests for more than twice. For the first time, after the replacement of the accessories is complete, wait for the hashboard to cool down and perform fixture test, after passing, set it aside and then cool it down; for the second time, wait for a few minutes until the hashboard is completely cooled before testing.

• After the board is repaired, relevant maintenance / analysis records (requirements for maintenance reports: date, SN, PCB version, tag number, bad cause, bad liability attribution, etc.) should be prepared for feedback to production, after-sales, research and development departments.

• After the record is prepared, install the entire machine for conventional aging.

• Good products repaired at the production end should flow production from the first station of production (at least conduct the appearance inspection and start from the PT1 / PT2 test station)!

